

MOSFET - N-Channel, Shielded Gate POWERTRENCH®

60 V, 84 A, 4.3 m Ω

FDMC86570L

General Description

This N-Channel MOSFET is produced using **onsemi's** advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 4.3 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 18 \text{ A}$
- Max $r_{DS(on)} = 6.5 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 15 \text{ A}$
- ullet High Performance Technology for Extremely Low $r_{DS(on)}$
- These Devices are Pb-Free and are RoHS Compliant

Application

• DC-DC Conversion

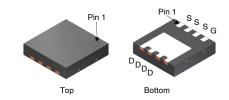
MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Units
VDS	Drain to Source Voltage	60	V
Vgs	Gate to Source Voltage	±20	V
I _D	$ \begin{array}{lll} \text{Drain Current} \\ -\text{Continuous} & & & & & \\ -\text{Continuous} & & & & \\ -\text{Pulsed} & & & & \\ \end{array} $	84 53 18 416	А
Eas	Single Pulse Avalanche Energy (Note 3)	253	mJ
P _D	Power Dissipation T _C = 25°C	54	W
	Power Dissipation T _A = 25°C (Note 1a)	2.3	
ТJ, Tsтg	Operating and Storage Junction Temperature Range	–55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
R _θ JC	Thermal Resistance, Junction-to-Case (Note 1)	2.3	°C/W
Reja	Thermal Resistance, Junction-to-Ambient (Note 1a)	53	°C/W



WDFN8 3.3x3.3, 0.65P CASE 483AW

MARKING DIAGRAM

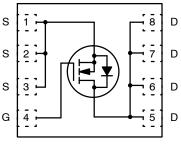


Z = Assembly Plant Code

X = Year Code YY = Week Code KK = Lot Code

FDMC = Specific Device Code 86570L = Specific Device Code

PIN ASSIGNMENT



N-Channel MOSFET

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

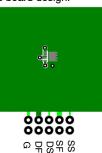
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARAC	TERISTICS			-	-	-
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			٧
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		30		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARACT	TERISTICS	•		-	-	-
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.8	3.0	٧
$\Delta V_{GS(th)}\!/\!\Delta T_{J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C		-7		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18 A		3.1	4.3	mΩ
		V _{GS} = 4.5 V, I _D = 15 A		4.7	6.5	1
		V _{GS} = 10 V, I _D = 18 A, T _J = 125°C		5.0	6.9	1
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 18 A		75		S
DYNAMIC CH	ARACTERISTICS					-
C _{iss}	Input Capacitance	V _{DS} = 30 V, V _{GS} = 0 V,		4790	6705	pF
C _{oss}	Output Capacitance	f = 1 MHz		821	1150	pF
C _{rss}	Reverse Transfer Capacitance			19	30	pF
R_g	Gate Resistance		0.1	0.9	2.7	Ω
SWITCHING C	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 30 \text{ V}, I_D = 18 \text{ A}, V_{GS} = 10 \text{ V},$		19	34	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$		6.2	12	ns
t _{d(off)}	Turn-Off Delay Time			38	61	ns
t _f	Fall Time			3.9	10	ns
Q _{g(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V V _{DD} = 30 V		63	88	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $I_D = 18 \text{ A}$		29	41	nC
Qgs	Gate to Source Charge			14		nC
Qgd	Gate to Drain "Miller" Charge			6.3		nC
DRAIN-SOUR	CE DIODE CHARACTERISTICS			•	•	•
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 18 A (Note 2)		0.8	1.3	V
		V _{GS} = 0 V, I _S = 1.9 A (Note 2)		0.7	1.2	1
t _{rr}	Reverse Recovery Time	I _F = 18 A, di/dt = 100 A/μs		43	69	ns
Q _{rr}	Reverse Recovery Charge			26	42	nC

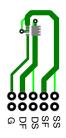
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in 2 pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.
 E_{AS} of 253 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 13 A, V_{DD} = 60 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 43 A.
 Pulsed I_D please refer to Figure 11 SOA graph for more details.
 Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

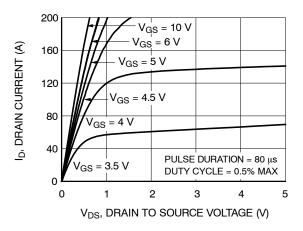


Figure 1. On-Region Characteristics

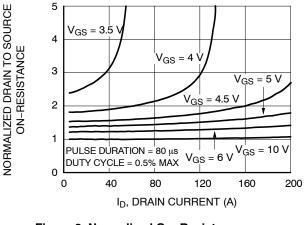


Figure 2. Normalized On–Resistance vs.
Drain Current and Gate Voltage

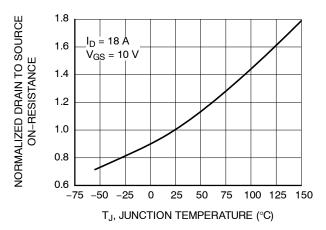


Figure 3. Normalized On–Resistance vs. Junction Temperature

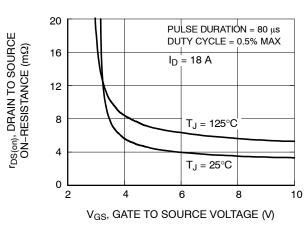


Figure 4. On-Resistance vs. Gate to Source Voltage

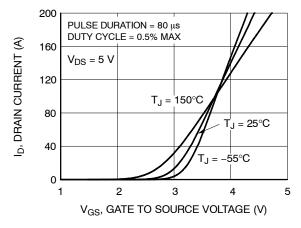


Figure 5. Transfer Characteristics

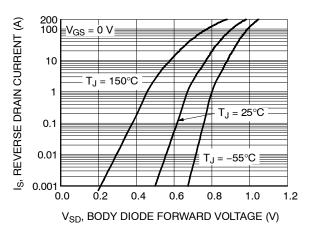


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

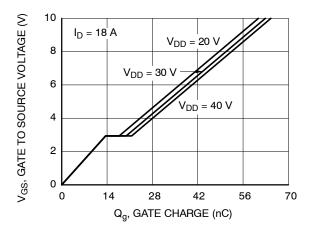


Figure 7. Gate Charge Characteristics

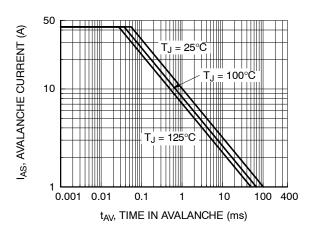


Figure 9. Unclamped Inductive Switching Capability

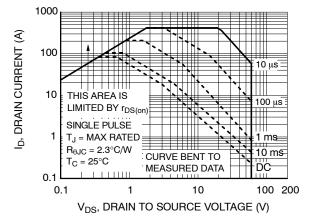


Figure 11. Forward Bias Safe Operating Area

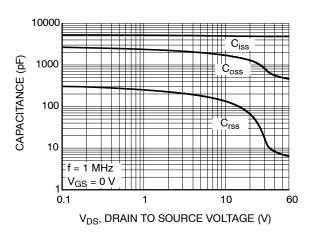


Figure 8. Capacitance vs. Drain to Source Voltage

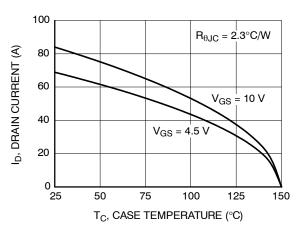


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

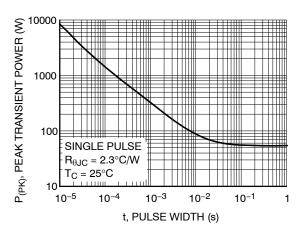


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

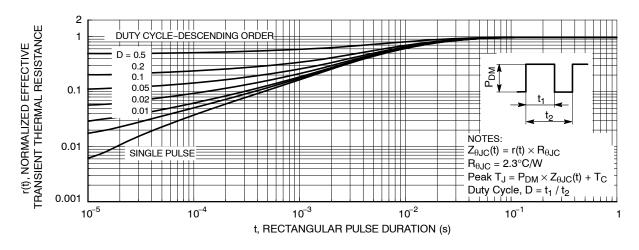


Figure 13. Junction-to-Case Transient Thermal Response Curve

ORDERING INFORMATION

Device	Device Marking	Package Type	Shipping [†]
FDMC86570L	FDMC86570L	WDFN8 3.3x3.3, 0.65P (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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TERMINAL #1

INDEX AREA

(D/2 X E/2)

⊃ aaa C

WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

DATE 22 MAR 2024

NOTES:

С

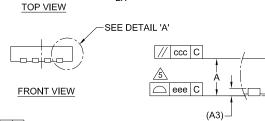
SEATING

PLANE

<u></u>

DETAIL A

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- ©COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



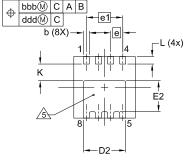
2X

aaa C

Α

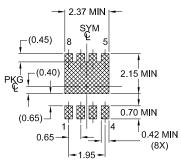
5

В



BOTTOM VIEW

LAND PATTERN RECOMMENDATION



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

MILLIMETERS DIM MIN NOM MAX 0.70 0.75 Α 0.80 Α1 0.05 А3 0.20 REF b 0.27 0.32 0.37 D 3.30 BSC D2 2.17 2.27 2.37 Ε 3.30 BSC E2 1.56 1.66 1.76 е 0.65 BSC 1.95 BSC e1 Κ 0.90 L 0.30 0.40 0.50 0.10 aaa bbb 0.10 0.10 CCC ddd 0.05 0.05 eee

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	WDFN8 3.30x3.30x0.75, 0.65P		PAGE 1 OF 1	

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